

**Notice of References Cited**

Application/Control No.

10/803,940

Applicant(s)/Patent Under  
Reexamination  
TAKEYAMA ET AL.

Examiner

KENDRICK X. LIU

Art Unit

4193

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,075,547 A	06-2000	Takeuchi, Hiroaki	347/116
*	B	US-6,222,566 B1	04-2001	Takeyama et al.	347/116
*	C	US-6,263,178 B1	07-2001	Takeyama et al.	399/228
*	D	US-2002/0037178 A1	03-2002	Saitoh et al.	399/110
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.